

Search Notes 	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/688,829	NAGAI ET AL.
	Examiner	Art Unit
	Lee Y Quach	2875

Search Notes



Application/Control No.

10/688,829

Examiner

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**Applicant(s)/Patent under
Reexamination**

NAGAI ET AL.

Art Unit

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INTERFERENCE SEARCHED

Class	Subclass	Date	Examiner

SEARCH NOTES (INCLUDING SEARCH STRATEGY)